

Search Notes

Application/Control No.

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Examiner

Linh T. Nguyen

Applicant(s)/Patent under
Reexamination

HORIKAWA ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text searched on East and foreign application.	5/12/2006	LN